


<b>Search Notes</b>  	<b>Application/Control No.</b>  10563429	<b>Applicant(s)/Patent Under Reexamination</b>  INOUE, FUJIO
	<b>Examiner</b>  Chen-Wen Jiang	<b>Art Unit</b>  3744

SEARCHED			
Class	Subclass	Date	Examiner
236	93A,93R,101C		
123	41.08		
137	468	5/26/09	CJ

SEARCH NOTES		
Search Notes	Date	Examiner
EAST Searched		
Inventor Searched	5/26/09	CJ
Search Updated		
Interference Search Printed	12/7/09	CJ

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
236	101C	12/7/09	CJ

--	--